Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/743,327	BAE ET AL.
Examiner	Art Unit
Gonal C. Ray	2111

	SEARCHED				
Class	Subclass	Date	Examiner		
710	100,300,3 01,313,31 5,1	10/12/2005	GCR		
235	454	10/12/2005	GCR		
369	18,24.01	10/12/2005	GCR		
369	30.03	10/12/2005	GCR		
369	47.1	10/12/2005	GCR		
369	44.31	10/12/2005	GCR		
711	111,112	10/12/2005	GCR		
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	10/12/2005	GCR
EAST: USPT (see search history printouts)	10/12/2005	GCR
NPL: IEEE Xplore (see search history printouts)	10/12/2005	GCR